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STF24N60M2, STFI24N60M2, STFW24N60M2

N-channel 600 V, 0.168 Ω typ., 18 A MDmesh II Plus[™] low Q_g Power MOSFETs in TO-220FP, I²PAKFP and TO-3PF packages

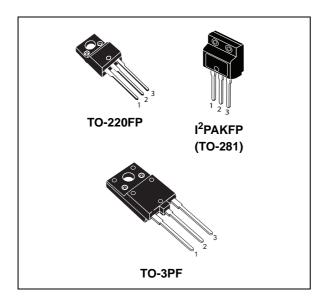
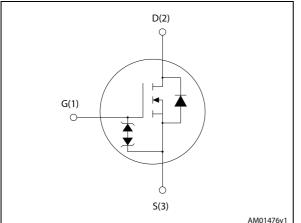


Figure 1. Internal schematic diagram



Features

Order codes	$\rm V_{DS} \ @ T_{Jmax}$	R _{DS(on)} max	I _D
STF24N60M2			
STFI24N60M2	650 V	0.19 Ω	18 A
STFW24N60M2			

Datasheet – production data

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

- Switching applications
- LLC converters, resonant converters

Description

These devices are N-channel Power MOSFETs developed using a new generation of MDmeshTM technology: MDmesh II PlusTM low Q_g. These revolutionary Power MOSFETs associate a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. They are therefore suitable for the most demanding high efficiency converters.

Table	1.	Device	summary
Table		DCVICC	Summary

Order codes	Marking	Package	Packaging
STF24N60M2		TO-220FP	
STFI24N60M2	24N60M2	I ² PAKFP (TO-281)	Tube
STFW24N60M2		TO-3PF	

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This is information on a product in full production.

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5	Revision history



1 Electrical ratings

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		Valu			
Symbol	Parameter	TO-220FP, I ² PAKFP	TO-3PF	Unit	
V _{GS}	Gate-source voltage	± 2	5	V	
I _D	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	18 ⁽	1)	А	
Ι _D	Drain current (continuous) at T _C = 100 °C	12 (А		
I _{DM} ⁽²⁾	Drain current (pulsed)	72 (А		
P _{TOT}	Total dissipation at $T_C = 25 \text{ °C}$ 30 48		48	W	
dv/dt ⁽³⁾	Peak diode recovery voltage slope	15		V/ns	
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50		V/ns	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C)	2500 3500		V	
T _{stg}	Storage temperature	- 55 to 150		°C	
Тj	Max. operating junction temperature	- 55 10	0		

Table 2. Absolute maximum ratings

1. Limited by maximum junction temperature.

2. Pulse width limited by safe operating area.

3. $I_{SD} \leq$ 18 A, di/dt \leq 400 A/ μ s; V_{DS peak} < V_{(BR)DSS}, V_{DD} = 400 V.

 $4. \quad V_{DS} \leq 480 \ V$

Table 3. Thermal data

		Valu		
Symbol	Symbol Parameter		TO-3PF	Unit
R _{thj-case}	Thermal resistance junction-case max	4.2	2.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	50	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax})$	3.5	А
E _{AS}	Single pulse avalanche energy (starting $T_j=25^{\circ}C$, $I_D=I_{AR}$; $V_{DD}=50$)	180	mJ



Electrical characteristics 2

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	V _{GS} = 0, I _D = 1 mA	600			V
	Zero gate voltage	$V_{GS} = 0, V_{DS} = 600 V$			1	μA
I _{DSS} drain current	v v	V _{GS} = 0, V _{DS} = 600 V, T _C =125 °C			100	μA
I _{GSS}	Gate-body leakage current	V _{DS} = 0, V _{GS} = ± 25 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu$ A	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 9 A		0.168	0.19	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1060	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	55	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	2.2	-	pF
C _{oss eq.} ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	258	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D =0	-	7	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 18 A,	-	29	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	6	-	nC
Q _{gd}	Gate-drain charge	(see Figure 16)	-	12	-	nC

1. $C_{oss eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}



Table 7. Switching times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	14	-	ns
t _r	Rise time	V _{DD} = 300 V, I _D = 9 A, R _G = 4.7 Ω, V _{GS} = 10 V	-	9	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 16 and 21)	-	60	-	ns
t _f	Fall time		-	15	-	ns

Table 7. Switching times

Table	8.	Source	drain	diode
	•••	000000	a. a	

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} ⁽¹⁾	Source-drain current		-		18	А
I _{SDM} ^{(1),(2)}	Source-drain current (pulsed)	drain current (pulsed)			72	А
V _{SD} ⁽³⁾	Forward on voltage	I _{SD} = 18 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 18 A, di/dt = 100 A/µs V _{DD} = 60 V (see <i>Figure 18</i>)	-	332		ns
Q _{rr}	Reverse recovery charge		-	4		μC
I _{RRM}	Reverse recovery current		-	24		А
t _{rr}	Reverse recovery time	I _{SD} = 18 A, di/dt = 100 A/µs	-	450		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C	-	5.5		μC
I _{RRM}	Reverse recovery current	(see Figure 18)	-	25		А

1. The value is rated according to ${\rm R}_{\rm thj\text{-}case}$ and limited by package.

2. Pulse width limited by safe operating area

3. Pulsed: pulse duration = $300 \,\mu$ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220FP and Figure 3. Thermal impedance for TO-220FP and

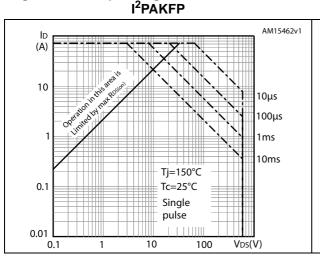
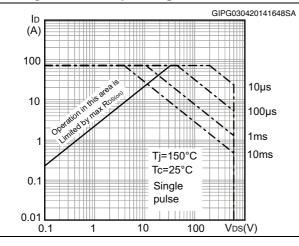
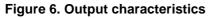


Figure 4. Safe operating area for TO-3PF





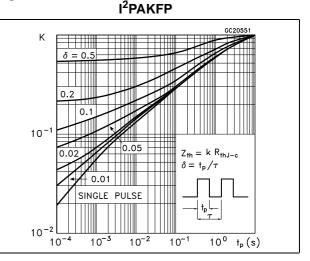


Figure 5. Thermal impedance for TO-3PF

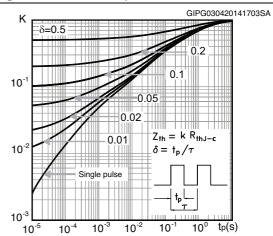


Figure 7. Transfer characteristics

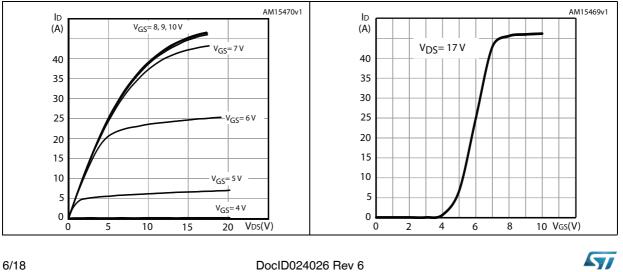


Figure 8. Gate charge vs gate-source voltage Figure 9. Static drain-source on-resistance AM15471v1 AM15465v1 RDS(on) Vgs Vds (Ω) (V) (V) VDD=480 V VGS=10V 12 VDS 600 ID=18 A 0.176 500 10 0.172 8 400 300 6 0.168 200 4 0.164 2 100 0.160 0 0 25 30 Qg(nC) 4 8 16 ID(A) 5 10 15 20 12 0 0

Figure 10. Capacitance variations

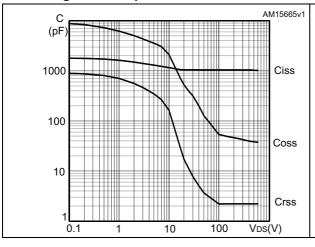


Figure 12. Normalized gate threshold voltage vs temperature

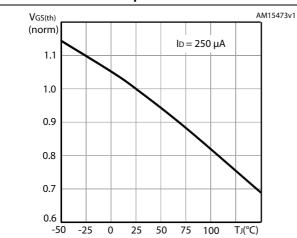


Figure 11. Output capacitance stored energy

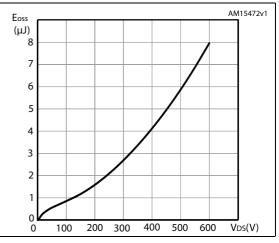


Figure 13. Normalized on-resistance vs temperature

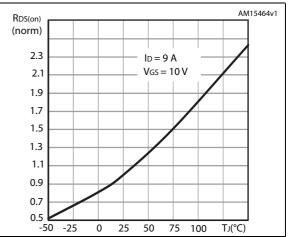
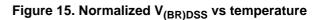
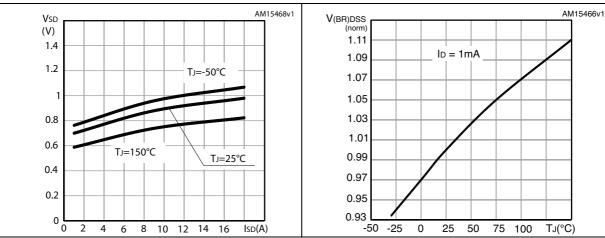




Figure 14. Source-drain diode forward characteristics







3 Test circuits

Figure 16. Switching times test circuit for resistive load

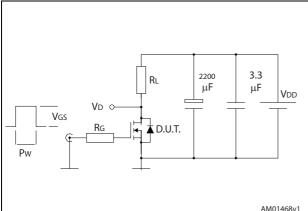


Figure 18. Test circuit for inductive load switching and diode recovery times

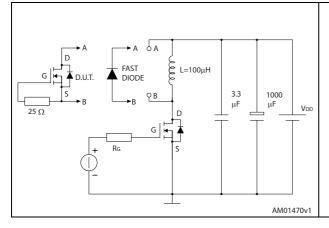
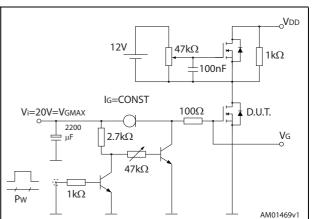
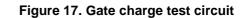
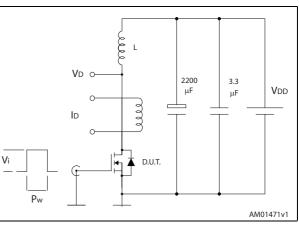


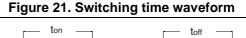
Figure 20. Unclamped inductive waveform

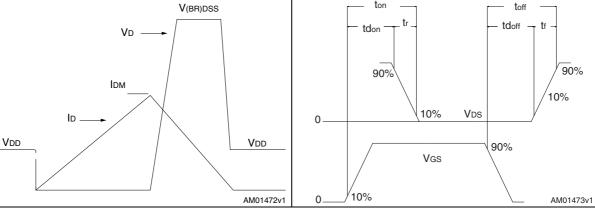














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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

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4.1 TO-220FP, STF24N60M2

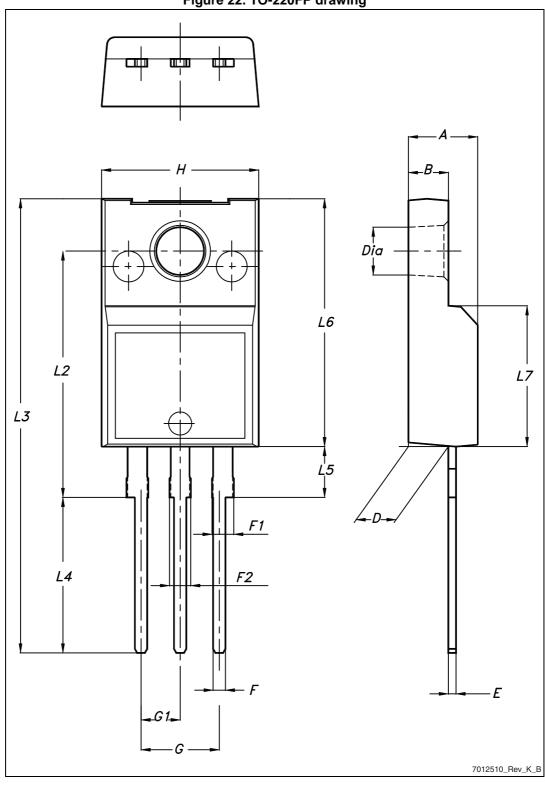


Figure 22. TO-220FP drawing



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Dim.	mm			
	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

Table 9. TO-220FP mechanical data



4.2 I²PAKFP, STFI24N60M2

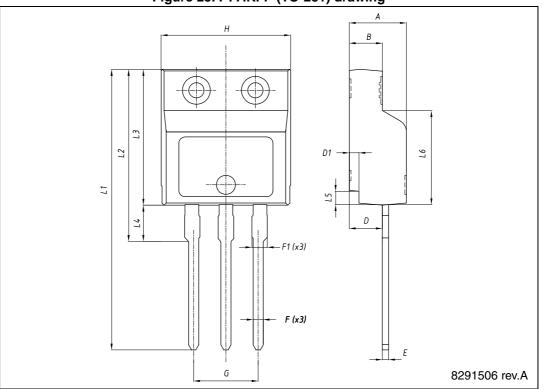


Figure 23. I²PAKFP (TO-281) drawing



Dim.	mm			
	Min.	Тур.	Max.	
А	4.40		4.60	
В	2.50		2.70	
D	2.50		2.75	
D1	0.65		0.85	
E	0.45		0.70	
F	0.75		1.00	
F1			1.20	
G	4.95	-	5.20	
Н	10.00		10.40	
L1	21.00		23.00	
L2	13.20		14.10	
L3	10.55		10.85	
L4	2.70		3.20	
L5	0.85		1.25	
L6	7.30		7.50	

Table 10. I²PAKFP (TO-281) mechanical data



4.3 TO-3PF, STFW24N60M2

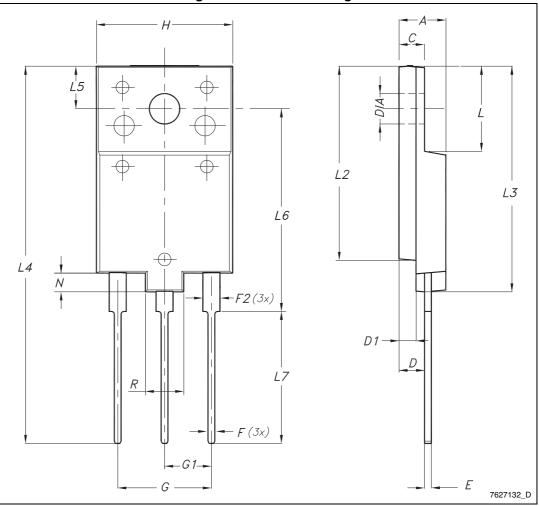


Figure 24. TO-3PF drawing



Table 11. TO-3PF mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
А	5.30		5.70	
С	2.80		3.20	
D	3.10		3.50	
D1	1.80		2.20	
E	0.80		1.10	
F	0.65		0.95	
F2	1.80		2.20	
G	10.30		11.50	
G1		5.45		
Н	15.30		15.70	
L	9.80	10	10.20	
L2	22.80		23.20	
L3	26.30		26.70	
L4	43.20		44.40	
L5	4.30		4.70	
L6	24.30		24.70	
L7	14.60		15	
Ν	1.80		2.20	
R	3.80		4.20	
Dia	3.40		3.80	

Table 11. TO-3PF mechanical data

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5 Revision history

Date	Revision	Changes
10-Dec-2012	1	First release.
20-Dec-2012	2	Added MOSFET dv/dt ruggedness in <i>Table 2: Absolute maximum ratings</i> .
14-Jan-2013	3 Modified: <i>Figure 16</i> , 17	
28-May-2013	4 – Modified: <i>Figure 16, 17, 18</i> and <i>19</i> – Minor text changes	
28-Feb-2014 5 – Modified: R _{thj-case} value in <i>Table 3</i> – Modified: <i>Figure 12</i> – Minor text changes		– Modified: Figure 12
07-Apr-2014 6 – Added: TO-3PF package 07-Apr-2014 6 – Added: Section 4.3: TO-3PF, STFW24N60M2 – Minor text changes		- Added: Section 4.3: TO-3PF, STFW24N60M2

Table 12. Document revision history



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